

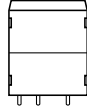


## SIOV metal oxide varistors

### Housed (ThermoFuse) varistors, AdvancedD series

Series/Type: ETFV14  
Date: April 2011





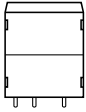
## Electrical specifications and ordering codes

 Maximum ratings ( $T_A = 85\text{ °C}$ )

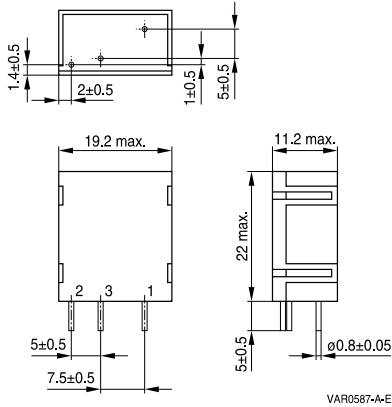
Ordering code	Type (untaped) SIOV-	$V_{RMS}$ V	$V_{DC}$ V	$i_{max}$ (8/20 $\mu$ s) A	$W_{max}$ (2 ms) J	$P_{max}$ W
B72214T2131K101	ETFV14K130E2	130	170	6000	50	0.6
B72214T2141K101	ETFV14K140E2	140	180	6000	55	0.6
B72214T2151K101	ETFV14K150E2	150	200	6000	60	0.6
B72214T2171K101	ETFV14K175E2	175	225	6000	70	0.6
B72214T2211K101	ETFV14K210E2	210	270	6000	80	0.6
B72214T2231K101	ETFV14K230E2	230	300	6000	90	0.6
B72214T2251K101	ETFV14K250E2	250	320	6000	100	0.6
B72214T2271K101	ETFV14K275E2	275	350	6000	110	0.6
B72214T2301K101	ETFV14K300E2	300	385	6000	125	0.6
B72214T2321K101	ETFV14K320E2	320	420	6000	136	0.6
B72214T2351K101	ETFV14K350E2	350	460	6000	136	0.6
B72214T2381K101	ETFV14K385E2	385	505	6000	136	0.6
B72214T2421K101	ETFV14K420E2	420	560	6000	136	0.6

 Characteristics ( $T_A = 25\text{ °C}$ )

Ordering code	Type (untaped) SIOV-	$V_V$ (1 mA) V	$DV_V$ (1 mA) %	$V_{c,max}$ ( $i_c$ ) V	$i_c$ A	$C_{typ}$ (1 kHz) pF
B72214T2131K101	ETFV14K130E2	205	$\pm 10$	340	50	650
B72214T2141K101	ETFV14K140E2	220	$\pm 10$	360	50	610
B72214T2151K101	ETFV14K150E2	240	$\pm 10$	395	50	570
B72214T2171K101	ETFV14K175E2	270	$\pm 10$	455	50	490
B72214T2211K101	ETFV14K210E2	330	$\pm 10$	545	50	410
B72214T2231K101	ETFV14K230E2	360	$\pm 10$	595	50	380
B72214T2251K101	ETFV14K250E2	390	$\pm 10$	650	50	350
B72214T2271K101	ETFV14K275E2	430	$\pm 10$	710	50	320
B72214T2301K101	ETFV14K300E2	470	$\pm 10$	775	50	300
B72214T2321K101	ETFV14K320E2	510	$\pm 10$	840	50	280
B72214T2351K101	ETFV14K350E2	560	$\pm 10$	910	50	260
B72214T2381K101	ETFV14K385E2	620	$\pm 10$	1025	50	240
B72214T2421K101	ETFV14K420E2	680	$\pm 10$	1120	50	220



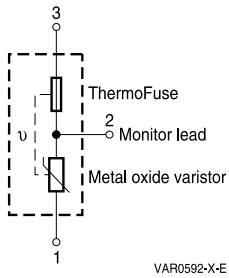
Dimensional drawings

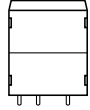


Weight

Nominal diameter mm	V <sub>RMS</sub> V	Weight g
14	130 ... 420	4.0 ... 5.6

Lead configuration

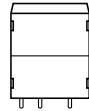



**Reliability data**

Test	Test methods/conditions	Requirement
Varistor voltage	The voltage between two terminals with the specified measuring current applied is called $V_V$ (1 mA <sub>DC</sub> @ 0.2 ... 2 s).	To meet the specified value
Clamping voltage	The maximum voltage between two terminals with the specified standard impulse current (8/20 µs) applied.	To meet the specified value
Endurance at upper category temperature	1000 h at UCT After having continuously applied the maximum allowable AC voltage at UCT ±2 °C for 1000 h, the specimen shall be stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of $V_V$ shall be measured.	DV/V (1 mA)  £10%
Surge current derating, 8/20 ms	10 surge currents (8/20 ms), unipolar, interval 30 s, amplitude corresponding to derating curve for 10 impulses at 20 ms	DV/V (1 mA)  £10% (measured in direction of surge current) No visible damage
Surge current derating, 2 ms	10 surge currents (2 ms), unipolar, interval 120 s, amplitude corresponding to derating curve for 10 impulses at 2 ms	DV/V (1 mA)  £10% (measured in direction of surge current) No visible damage
Electric strength	IEC 61051-1, test 4.9.2 Metal balls method, 2500 V <sub>RMS</sub> , 60 s The varistor is placed in a container holding 1.6 ±0.2 mm diameter metal balls such that only the terminations of the varistor are protruding. The specified voltage shall be applied between both terminals of the specimen connected together and the electrode inserted between the metal balls.	No breakdown



Test	Test methods/conditions	Requirement
Climatic sequence	<p>The specimen shall be subjected to:</p> <p>a) dry heat at UCT, 16 h, IEC 60068-2-2, test Ba</p> <p>b) damp heat, 1st cycle: 55 °C, 93% r. H., 24 h, IEC 60068-2-30, test Db</p> <p>c) cold, LCT, 2 h, IEC 60068-2-1, test Aa</p> <p>d) damp heat, additional 5 cycles: 55 °C/25 °C, 93% r. H., 24 h/cycle, IEC 60068-2-30, test Db.</p> <p>Then the specimen shall be stored at room temperature and normal humidity for 1 to 2 h.</p> <p>Thereafter, the change of <math>V_V</math> shall be measured. Thereafter, insulation resistance <math>R_{ins}</math> shall be measured at <math>V = 500</math> V.</p>	<p><math> DV/V (1 \text{ mA})  \leq 10\%</math></p> <p><math>R_{ins} \geq 100 \text{ MW}</math></p>
Rapid change of temperature	IEC 60068-2-14, test Na, LCT/UCT, dwell time 30 min, 5 cycles	<p><math> DV/V (1 \text{ mA})  \leq 5\%</math></p> <p>No visible damage</p>
Damp heat, steady state	<p>IEC 60068-2-78, test Ca</p> <p>The specimen shall be subjected to <math>40 \pm 2</math> °C, 90 to 95% r. H. for 56 days without load / with 10% of the maximum continuous DC operating voltage <math>V_{DC}</math>. Then stored at room temperature and normal humidity for 1 to 2 h.</p> <p>Thereafter, the change of <math>V_V</math> shall be measured. Thereafter, insulation resistance <math>R_{ins}</math> shall be measured at <math>V = 500</math> V (insulated varistors only).</p>	<p><math> DV/V (1 \text{ mA})  \leq 10\%</math></p> <p><math>R_{ins} \geq 100 \text{ MW}</math></p>

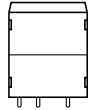


Test	Test methods/conditions	Requirement
Solderability	<p>IEC 60068-2-20, test Ta, method 1 with modified conditions for lead-free solder alloys: 245 °C, 3 s:</p> <p>After dipping the terminals to a depth of approximately 3 mm from the body in a soldering bath of 245 °C for 3 s, the terminals shall be visually examined.</p>	<p>The inspection shall be carried out under adequate light with normal eyesight or with the assistance of a magnifier capable of giving a magnification of 4 to 10 times. The dipped surface shall be covered with a smooth and bright solder coating with no more than small amounts of scattered imperfections such as pinholes or un-wetted or de-wetted areas. These imperfections shall not be concentrated in one area.</p>
Resistance to soldering heat	<p>IEC 60068-2-20, test Tb, method 1A, 260 °C, 10 s:</p> <p>Each lead shall be dipped into a solder bath having a temperature of 260 ±5 °C to a point 2.0 to 2.5 mm from the body of the specimen, be held there for 10 ±1 s and then be stored at room temperature and normal humidity for 1 to 2 h.</p> <p>The change of <math>V_V</math> shall be measured and the specimen shall be visually examined.</p>	<p> DV/V (1 mA)  £5%</p> <p>No visible damage</p>
Tensile strength	<p>IEC 60068-2-21, test Ua1</p> <p>After gradually applying the force specified below and keeping the unit fixed for 10 s, the terminal shall be visually examined for any damage.</p> <p>Force for wire diameter:</p> <p>0.6 mm = 10 N 0.8 mm = 10 N 1.0 mm = 20 N</p>	<p> DV/V (1 mA)  £5%</p> <p>No break of solder joint, no wire break</p>



Test	Test methods/conditions	Requirement
Vibration	IEC 60068-2-6, test Fc, method B4 Frequency range: 10 ... 55 Hz Amplitude: 0.75 mm or 98 m/s <sup>2</sup> Duration: 6 h (3 · 2 h) Pulse: sine wave After repeatedly applying a single harmonic vibration according to the table above. The change of $V_v$ shall be measured and the specimen shall be visually examined.	$ DV/V (1 \text{ mA})  \leq 5\%$ No visible damage
Bump	IEC 60068-2-29, test Eb Pulse duration: 6 ms Max. acceleration: 400 m/s <sup>2</sup> Number of bumps: 4000 Pulse: half sine	$ DV/V (1 \text{ mA})  \leq 5\%$ No visible damage
Fire hazard	IEC 60695-11-5 (needle flame test) Severity: vertical 10 s	5 s max.





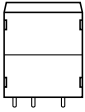
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Abnormal overvoltage test	The device is designed to meet the limited current abnormal overvoltage condition, outlined in section 39.4 of UL 1449, 3 <sup>rd</sup> edition. Detailed test voltage applied onto the device for different types as in the following table:	<p>Any of these phenomena shall not be observed, or this specimen will be judged as failed part:</p> <ol style="list-style-type: none"> <li>1. Emission of flame, molten metal, glowing or flaming particles through any openings (pre-existed or created as a result of the test) in the product.</li> <li>2. Charring, glowing, or flaming of the supporting surface, tissue paper, or cheesecloth.</li> <li>3. Ignition of the enclosure.</li> <li>4. Creation of any openings in the enclosure that result in accessibility of live parts, when evaluated in accordance with accessibility of live parts test in section 58.2 of UL1449, 3<sup>rd</sup> edition.</li> </ol>																																										
	<table border="1"> <thead> <tr> <th>Type</th> <th>Device rating V</th> <th>Test voltage V</th> </tr> </thead> <tbody> <tr> <td>ETFV14K130E2</td> <td>130</td> <td>260</td> </tr> <tr> <td>ETFV14K140E2</td> <td>140</td> <td>280</td> </tr> <tr> <td>ETFV14K150E2</td> <td>150</td> <td>300</td> </tr> <tr> <td>ETFV14K175E2</td> <td>175</td> <td>350</td> </tr> <tr> <td>ETFV14K210E2</td> <td>210</td> <td>420</td> </tr> <tr> <td>ETFV14K230E2</td> <td>230</td> <td>415</td> </tr> <tr> <td>ETFV14K250E2</td> <td>250</td> <td>500</td> </tr> <tr> <td>ETFV14K275E2</td> <td>275</td> <td>480</td> </tr> <tr> <td>ETFV14K300E2</td> <td>300</td> <td>600</td> </tr> <tr> <td>ETFV14K320E2</td> <td>320</td> <td>600</td> </tr> <tr> <td>ETFV14K350E2</td> <td>350</td> <td>600</td> </tr> <tr> <td>ETFV14K385E2</td> <td>385</td> <td>600</td> </tr> <tr> <td>ETFV14K420E2</td> <td>420</td> <td>600</td> </tr> </tbody> </table>		Type	Device rating V	Test voltage V	ETFV14K130E2	130	260	ETFV14K140E2	140	280	ETFV14K150E2	150	300	ETFV14K175E2	175	350	ETFV14K210E2	210	420	ETFV14K230E2	230	415	ETFV14K250E2	250	500	ETFV14K275E2	275	480	ETFV14K300E2	300	600	ETFV14K320E2	320	600	ETFV14K350E2	350	600	ETFV14K385E2	385	600	ETFV14K420E2	420	600
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Note:

UCT = Upper category temperature

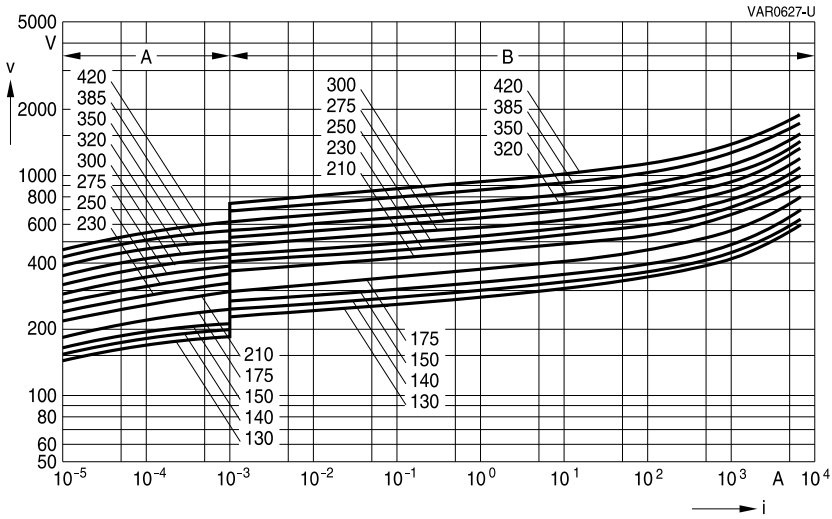
LCT = Lower category temperature

R<sub>ins</sub> = Insulation resistance

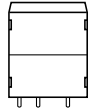


v/i characteristics

$v = f(i)$  for explanation of the characteristics refer to "General technical information", chapter 1.6.3  
 A = Leakage current, B = Protection level } for worst-case varistor tolerances



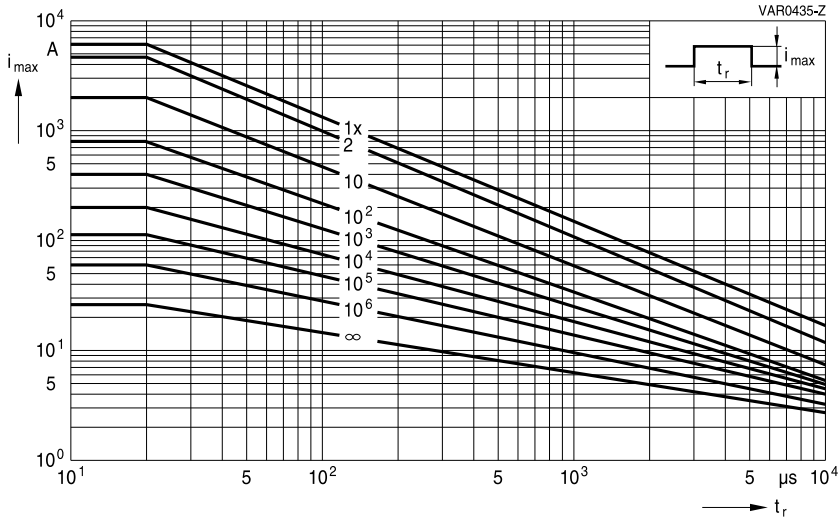
SIOV-ETFV14 ... E2



Derating curves

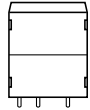
Maximum surge current  $i_{max} = f(t_r, \text{pulse train})$

For explanation of the derating curves refer to "General technical information", section 1.8.1



SIOV-ETFV14 ... E2



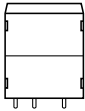


### Mounting

1. Potting, sealing or adhesive compounds can produce chemical reactions in the SIOV ceramic that will degrade the component's electrical characteristics.
2. Overloading SIOVs may result in ruptured packages and expulsion of hot materials. For this reason SIOVs should be physically shielded from adjacent components.

### Operation

1. Use SIOVs only within the specified temperature operating range.
2. Use SIOVs only within the specified voltage and current ranges.
3. Environmental conditions must not harm SIOVs. Use SIOVs only in normal atmospheric conditions. Avoid use in deoxidizing gases (chlorine gas, hydrogen sulfide gas, ammonia gas, sulfuric acid gas etc), corrosive agents, humid or salty conditions. Contact with any liquids and solvents should be prevented.


**Symbols and terms**

Symbol	Term
C	Capacitance
$C_{typ}$	Typical capacitance
i	Current
$i_c$	Current at which $V_{c, max}$ is measured
$I_{leak}$	Leakage current
$i_{max}$	Maximum surge current (also termed peak current)
$I_{max}$	Maximum discharge current to IEC 61643-1
$I_{nom}$	Nominal discharge current to IEC 61643-1
LCT	Lower category temperature
$L_{typ}$	Typical inductance
$P_{max}$	Maximum average power dissipation
$R_{ins}$	Insulation resistance
$R_{min}$	Minimum resistance
$T_A$	Ambient temperature
$t_r$	Duration of equivalent rectangular wave
UCT	Upper category temperature
v	Voltage
$V_{clamp}$	Clamping voltage
$V_{c, max}$	Maximum clamping voltage at specified current $i_c$
$V_{DC}$	DC operating voltage
$V_{jump}$	Maximum jump start voltage
$V_{max}$	Maximum voltage
$V_{op}$	Operating voltage
$V_{RMS}$	AC operating voltage, root-mean-square value
$V_{RMS, op, max}$	Root-mean-square value of max. DC operating voltage incl. ripple current
$V_{surge}$	Super imposed surge voltage
$V_V$	Varistor voltage
$DV_V$	Tolerance of varistor voltage
$W_{LD}$	Maximum load dump
$W_{max}$	Maximum energy absorption
$e$	Lead spacing

All dimensions are given in mm.

The commas used in numerical values denote decimal points.

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1. Some parts of this publication contain statements about the suitability of our products for certain areas of application. These statements are based on our knowledge of typical requirements that are often placed on our products in the areas of application concerned. We nevertheless expressly point out that such statements cannot be regarded as binding statements about the suitability of our products for a particular customer application. As a rule, EPCOS is either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always ultimately incumbent on the customer to check and decide whether an EPCOS product with the properties described in the product specification is suitable for use in a particular customer application.
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